

Application/Control	No.
10/734,428	

Examiner
TAN Q. NGUYEN

Applicant(s)/Patent under Reexamination PEETERS, ERIC

Art Unit 3661

	· · · · · ·		·····	<u>ISSUE</u>	: CL	<u>.AS</u>	SIF	ICAI	ION							
	INTERNATIONAL CLASSIFICATION															
CLASS SUBCLASS							Cl	AIMED		NON-CLAIMED						
	701		209		G	01	С	21	/34	G	09	В	29	/00		
					,											
CLASS	SUBCLA	1				,					,					
701	201	211	213						1					1		
340	995.19	995.23	23						1					1		
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(Assistant Examiner) (Date)

TAN Q. NGUYEN
PRIMARY EXAMINER (2010)

Total Claims Allowed: 12

O.G. Print Claim(s)

O.G. Print Fig.

	laims	renumbered in the same order as presented by applican						cant	ОС	PA	 ☐ T.D.			☐ R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original	Final	Original		Final	Original
	1			31			61	1		91			121		151			181
	2			32			62			92			122		152			182
	3			33			63]		93			123		153			183
	4			34			64			94			124		154		**********	184
	5			35			65]		95			125		155			185
	6			36			66			96			126		156			186
	7			37			67			97			127		157			187
	8			38			68]		98			128		158			188
	9			39			69			99			129		159			189
	10]		40]		70			100			130		160			190
	11	ļ		41			71]		101			131		161		,	191
	12		L	42]		72]		102			132		162			192
	13			43			73]		103			133		163			193
1	14			44]		74]		104			134		164			194
2	15]		45]		75			105			135		165			195
3	16			46			76] .		106			136		166			196
4	17	İ		47			77			107			137		167			197
5	18			48			78			108			138		168			198
6	19]		49			79]		109			139		169			199
	20			50			80]		110			140		170			200
L	21	ļ		51			81]		111			141		171			201
	22	[52	1		82]		112			142		172			202
7	23]		53	[83]		113			143		173			203
8	24	1		54]		84]		114			144		174			204
9	25			55			85			115			145		175			205
10	26			56			86]		116			146		176			206
11	27			57	[87			117			147		177			207
12	28			58			88			118			148		178			208
	29			59			89]		119			149		179			209
	30			60			90			120			150		180			210